

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re patent application of

*Wong* et al.

Serial No.: Not Yet Assigned

Group Art Unit: Not Yet Assigned

Filing Date: Concurrently Herewith

Examiner: Unknown

For: CMP SLURRY ADDITIVE FOR FOREIGN MATTER DETECTION

Assistant Commissioner of Patents  
Washington, D.C. 20231



**INFORMATION DISCLOSURE STATEMENT**

Sir:

Under the provisions of 37 CFR §1.97 through §1.99 and pursuant to applicants' duty of disclosure under 37 CFR §1.56, applicants respectfully bring the following documents listed on the attached form PTO-1449, to the attention of the Examiner in charge of the above-identified application. Copies of the listed documents are provided herewith for the convenience of the Examiner.

This citation does not constitute an admission that the references are relevant or material to the claims. They are only cited as constituting related art of which the applicants are aware.

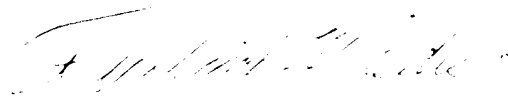
It is respectfully requested that the listed references be considered by the Examiner and formally made of record in this application.

FIS9-2001-0166

Please charge any deficiencies in fees and credit any overpayment of fees to Attorney's

Deposit Account No. 09-0458.

Respectfully submitted,

A handwritten signature in cursive script, appearing to read "Frederick W. Gibbs, III".

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<b>INFORMATION DISCLOSURE CITATION</b> <i>(Use several sheets if necessary.)</i>	Docket Number (Optional) <b>FIS9-2001-0166</b>	Application Number <b>Not Yet Assigned</b>
	Applicant(s) <b>Boggs et al.</b>	
	Filing Date <b>Concurrently Herewith</b>	Group Art Unit <b>Not Yet Assigned</b>

**U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
		3,443,092	05/06/1969	Carr-Brion et al.			
		5,320,706	06/14/1994	Blackwell			
		5,483,568	01/09/1996	Yano et al.			
		5,704,987	01/06/1998	Huynh et al.			
		5,807,605	09/15/1998	Tingey et al.			
		5,922,606	07/13/1999	Jenkins et al.			

J1046 U.S. PTO  
 10/05/98  
 01/24/02

**FOREIGN PATENT DOCUMENTS**

REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO

**OTHER DOCUMENTS** *(Including Author, Title, Date, Pertinent Pages, Etc.)*

		Burke, P., et al., "EVALUATION OF CONTAMINANT-INDUCED CHARGE FROM OXIDE CHEMICAL-MECHANICAL POLISH", Proceedings of the SPIE - The International Society for Optical Engineering Conference, Title: Proc. SPIE - Int. Soc. Opt. Eng. (USA), vol. 2638, p. 27-37, 1995.

EXAMINER	DATE CONSIDERED
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.